Search Notes				

Application/Control No.	Applicant(s)/Patent under Reexamination	
10/706,050	LEE ET AL.	
Examiner	Art Unit	
HOAN C. NGUYEN	2871	

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SEARCHED				
Class	Subclass	Date	Examiner	
349	61	7/26/2005	CHN	
345	84	7/26/2005	CHN	
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INTERFERENCE SEARCHED				
Class	Subclass	Date	Examiner	
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SEARCH NOTES (INCLUDING SEARCH STRATEGY)			
		DATE	EXMR
east search		7/26/2005	CHN
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